



# MJ N-Channel Enhancement Mode Power MOSFET

### Description

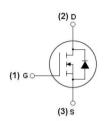
The MJ0208IA uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

#### General Features

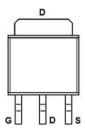
- ♦  $V_{DS} = 200V, I_{D} = 8A$  $R_{DS(ON)} < 300 m\Omega$  @  $V_{GS} = 10V$  (Typ:260 mΩ)
- ♦ High density cell design for ultra low Rdson
- ◆ Fully characterized avalanche voltage and current
- ◆ Low gate to drain charge to reduce switching losses

### Application

- ◆ Power switching application
- ◆ Hard switched and high frequency circuits
- Uninterruptible power supply







Marking and pin assignment



TO-251 top view

### 100% ΔVds TESTED!

# Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJ0208IA	MJ0208IA	TO-251	-	-	-

### Absolute Maximum Ratings (Tc=25℃ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	200	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	lo	8	А
Drain Current-Continuous(Tc =100℃)	ID(100°C)	5.6	А
Pulsed Drain Current	Ірм	20	А
Maximum Power Dissipation	Po	55	W
Operating Junction and Storage Temperature Range	Тл ,Тѕтс	-55 To 150	°C

## Thermal Characteristic

Thermal Resistance, Junction-to-Case (Note 2)	Rejc	2.3	°C/W	
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# Electrical Characteristics (Tc=25℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics	'					
Drain-Source Breakdown Voltage	BVDSS	V <sub>GS</sub> =0V I <sub>D</sub> =250µA	200	215	-	V
Zero Gate Voltage Drain Current	loss	V <sub>DS</sub> =200V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	lgss	V <sub>DS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	VGS(th)	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250µA	1	1.7	2.5	V
Drain-Source On-State Resistance	Rds(on)	V <sub>GS</sub> =10V, I <sub>D</sub> =4.5A	-	260	300	mΩ
Forward Transconductance	grs	V <sub>DS</sub> =25V,I <sub>D</sub> =4.5A	3	_	-	S
Dynamic Characteristics (Note 4)						
Input Capacitance	Clss		-	540	-	PF
Output Capacitance	Coss	V <sub>DS</sub> =25V,V <sub>GS</sub> =0V F=1.0MHz	-	90	-	PF
Reverse Transfer Capacitance	Crss		-	35	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t <sub>d(on)</sub>		-	6.4	-	nS
Turn-on Rise Time	tr	V <sub>DD</sub> =100V,I <sub>D</sub> =4.5A	-	11	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	V <sub>GS</sub> =10V,R <sub>GEN</sub> =5Ω	-	20	-	nS
Turn-Off Fall Time	tr	•	-	12	-	nS
Total Gate Charge	Qg		-	16	-	nC
Gate-Source Charge	Qgs	V <sub>DS</sub> =160V,I <sub>D</sub> =4.5A V <sub>GS</sub> =10V	-	3.4	-	nC
Gate-Drain Charge	Qgd		-	5.1	-	nC
Drain-Source Diode Characteristics		I	1	1		1
Diode Forward Voltage (Note 3)	VsD	V <sub>GS</sub> =0V,I <sub>S</sub> =4.5A	-	-	1.2	V
Diode Forward Current (Note 2)	Is		_	_	8	А

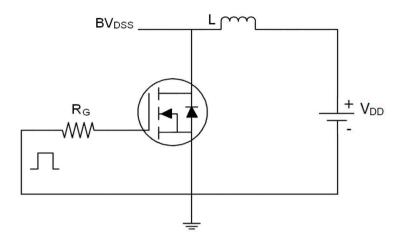
#### Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board,  $t \le 10$  sec.
- 3 Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2%.
- ④ Guaranteed by design, not subject to production

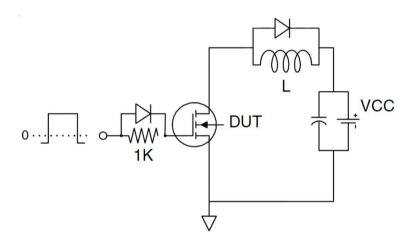




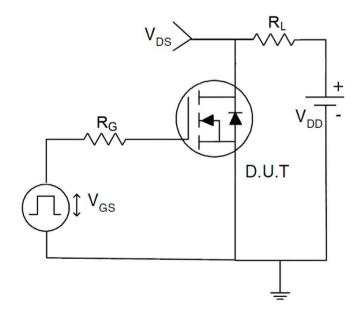
## Test circuit



Eas test Circuit



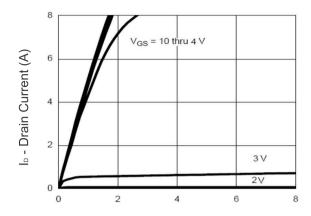
Gate charge test Circuit



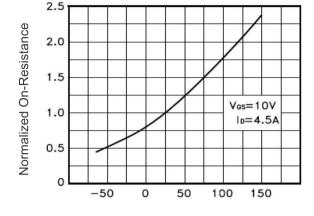
Switch Time Test Circuit



## Typical Electrical and Thermal Characteristics (Curves)

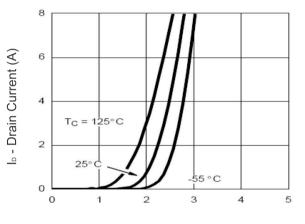


Vds Drain-Source Voltage (V)



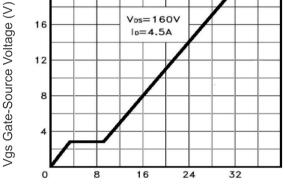
T<sub>J</sub> -Junction Temperature(°C)





Vgs Gate-Source Voltage (V)
Figure 2 Transfer Characteristics

Figure 4 Rdson-Junction Temperature



Qg Gate Charge (nC)
Figure 5 Gate Charge

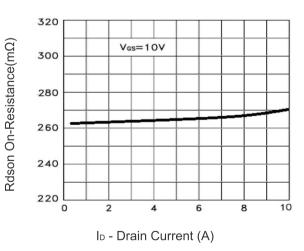


Figure 3 Rdson- Drain Current

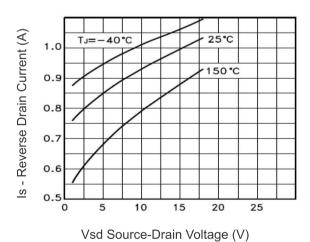
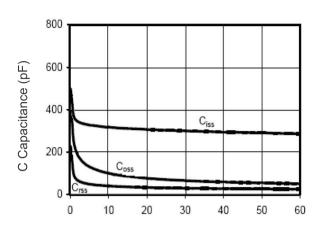


Figure 6 Source- Drain Diode Forward





Vds Drain-Source Voltage (V)
Figure 7 Capacitance vs Vds

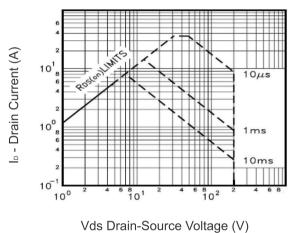
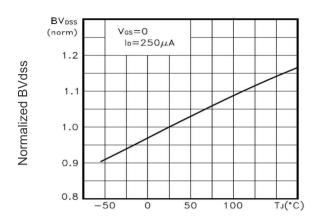
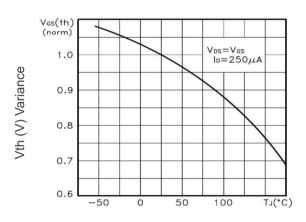


Figure 8 Safe Operation Area



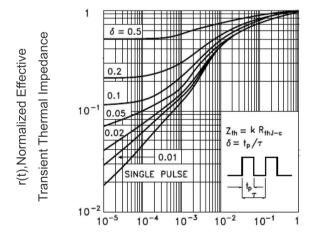
T<sub>J</sub> -Junction Temperature(°C)

Figure 9 BV<sub>DSS</sub> vs Junction Temperature



T<sub>J</sub> -Junction Temperature(°C)

Figure 10 V<sub>GS(th)</sub> vs Junction Temperature



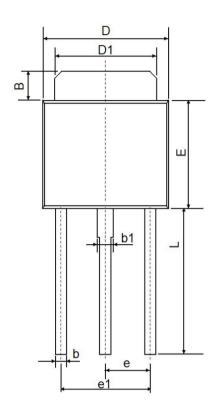
Square Wave Pluse Duration(sec)

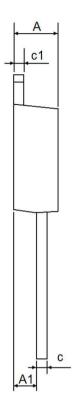
Figure 11 Normalized Maximum Transient Thermal Impedance





# TO-251 Package Information





Symbol	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
А	2.200	2.400	0.087	0.094
A1	1.050	1.350	0.042	0.054
В	1.350	1.650	0.053	0.065
b	0.500	0.700	0.020	0.028
b1	0.700	0.900	0.028	0.035
С	0.430	0.580	0.017	0.023
c1	0.430	0.580	0.017	0.023
D	6.350	6.650	0.250	0.262
D1	5.200	5.400	0.205	0.213
E	5.400	5.700	0.213	0.224
е	2.300	TYP	0.091	I TYP
e1	4.500	4.700	0.177	0.185
L	7.500	7.900	0.295	0.311





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